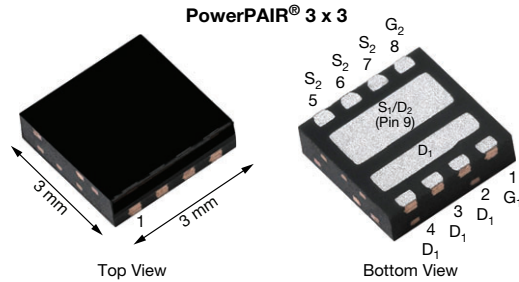


Dual N-Channel 30 V (D-S) MOSFETs



FEATURES

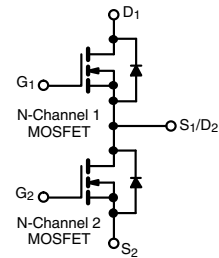
- TrenchFET® Gen IV power MOSFETs
- 100 % R_G and UIS tested
- PowerPAIR® integrated half-bridge MOSFET power stage
- Optimized Q_{gd}/Q_{gs} ratio improves switching characteristics
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912



RoHS
COMPLIANT
HALOGEN
FREE

APPLICATIONS

- CPU core power
- Computer / server peripherals
- POL
- Synchronous buck converter
- Telecom DC/DC



| PRODUCT SUMMARY | | |
|---|-----------|-----------|
| | CHANNEL-1 | CHANNEL-2 |
| V _{DS} (V) | 30 | 30 |
| R _{DS(on)} max. (Ω) at V _{GS} = 10 V | 0.00940 | 0.00429 |
| R _{DS(on)} max. (Ω) at V _{GS} = 4.5 V | 0.01440 | 0.00620 |
| Q _g typ. (nC) | 3.7 | 8.4 |
| I _D (A) ^a | 33.4 | 69.7 |
| Configuration | Dual | |

| ORDERING INFORMATION | |
|---------------------------------|------------------|
| Package | PowerPAIR 3 x 3 |
| Lead (Pb)-free and halogen-free | SiZ340ADT-T1-GE3 |

| ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted) | | | | | |
|---|-----------------------------------|------------------------|----------------------|----------------------|------|
| PARAMETER | SYMBOL | CHANNEL-1 | CHANNEL-2 | UNIT | |
| Drain-source voltage | V _{DS} | 30 | 30 | V | |
| Gate-source voltage | V _{GS} | +20, -16 | +16, -12 | | |
| Continuous drain current (T _J = 150 °C) | I _D | T _C = 25 °C | 33.4 | 69.7 | A |
| | | T _C = 70 °C | 26.7 | 55.7 | |
| | | T _A = 25 °C | 15.7 ^{b, c} | 25.4 ^{b, c} | |
| | | T _A = 70 °C | 13.7 ^{b, c} | 20.4 ^{b, c} | |
| Pulsed drain current (100 μs pulse width) | I _{DM} | 100 | 150 | A | |
| Continuous source drain diode current | I _S | T _C = 25 °C | 13.9 | | 25.8 |
| | | T _A = 25 °C | 3.1 ^{b, c} | 3.5 ^{b, c} | |
| Single pulse avalanche current | I _{AS} | 10 | 15 | mJ | |
| Single pulse avalanche energy | E _{AS} | 5 | 11 | | |
| Maximum power dissipation | P _D | T _C = 25 °C | 16.7 | 31 | W |
| | | T _C = 70 °C | 10.7 | 20 | |
| | | T _A = 25 °C | 3.7 ^{b, c} | 4.2 ^{b, c} | |
| | | T _A = 70 °C | 2.4 ^{b, c} | 2.7 ^{b, c} | |
| Operating junction and storage temperature range | T _J , T _{stg} | -55 to +150 | | °C | |
| Soldering recommendations (peak temperature) ^d | | 260 | | | |

| THERMAL RESISTANCE RATINGS | | | | | | | |
|---|--------------|-------------------|-----------|------|-----------|------|------|
| PARAMETER | | SYMBOL | CHANNEL-1 | | CHANNEL-2 | | UNIT |
| | | | TYP. | MAX. | TYP. | MAX. | |
| Maximum junction-to-ambient ^{b, f} | t ≤ 10 s | R _{thJA} | 27 | 34 | 24 | 30 | °C/W |
| Maximum junction-to-case (drain) | Steady state | R _{thJC} | 6 | 7.5 | 3.2 | 4 | |

Notes

- T_C = 25 °C
- Surface mounted on 1" x 1" FR4 board
- t = 10 s
- See solder profile (www.vishay.com/doc?73257). The PowerPAIR is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection
- Rework conditions: manual soldering with a soldering iron is not recommended for leadless components
- Maximum under steady state conditions is 69 °C/W for channel-1 and 64 °C/W for channel-2



| SPECIFICATIONS ($T_J = 25\text{ }^\circ\text{C}$, unless otherwise noted) | | | | | | | |
|--|-------------------------|--|------|------|---------|---------|---------------|
| PARAMETER | SYMBOL | TEST CONDITIONS | | MIN. | TYP. | MAX. | UNIT |
| Static | | | | | | | |
| Drain-source breakdown voltage | V_{DS} | $V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$ | Ch-1 | 30 | - | - | V |
| | | $V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$ | Ch-2 | 30 | - | - | |
| V_{DS} Temperature coefficient | $\Delta V_{DS}/T_J$ | $I_D = 10\text{ mA}$ | Ch-1 | - | 21 | - | mV/°C |
| | | | Ch-2 | - | 26 | - | |
| $V_{GS(th)}$ Temperature coefficient | $\Delta V_{GS(th)}/T_J$ | $I_D = 250\text{ }\mu\text{A}$ | Ch-1 | - | 5.3 | - | |
| | | | Ch-2 | - | 4.2 | - | |
| Gate threshold voltage | $V_{GS(th)}$ | $V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$ | Ch-1 | 1.1 | - | 2.4 | V |
| | | $V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$ | Ch-2 | 1.1 | - | 2.4 | |
| Gate source leakage | I_{GSS} | $V_{DS} = 0\text{ V}, V_{GS} = +20\text{ V} / -16\text{ V}$ | Ch-1 | - | - | 100 | nA |
| | | $V_{DS} = 0\text{ V}, V_{GS} = +16\text{ V} / -12\text{ V}$ | Ch-2 | - | - | 100 | |
| Zero gate voltage drain current | I_{DSS} | $V_{DS} = 30\text{ V}, V_{GS} = 0\text{ V}$ | Ch-1 | - | - | 1 | μA |
| | | $V_{DS} = 30\text{ V}, V_{GS} = 0\text{ V}$ | Ch-2 | - | - | 1 | |
| | | $V_{DS} = 30\text{ V}, V_{GS} = 0\text{ V}, T_J = 55\text{ }^\circ\text{C}$ | Ch-1 | - | - | 10 | |
| | | $V_{DS} = 30\text{ V}, V_{GS} = 0\text{ V}, T_J = 55\text{ }^\circ\text{C}$ | Ch-2 | - | - | 10 | |
| On-state drain current ^b | $I_{D(on)}$ | $V_{DS} \geq 5\text{ V}, V_{GS} = 10\text{ V}$ | Ch-1 | 15 | - | - | A |
| | | $V_{DS} \geq 5\text{ V}, V_{GS} = 10\text{ V}$ | Ch-2 | 15 | - | - | |
| Drain-source on-state resistance ^b | $R_{DS(on)}$ | $V_{GS} = 10\text{ V}, I_D = 10\text{ A}$ | Ch-1 | - | 0.00780 | 0.00940 | Ω |
| | | $V_{GS} = 10\text{ V}, I_D = 20\text{ A}$ | Ch-2 | - | 0.00357 | 0.00429 | |
| | | $V_{GS} = 4.5\text{ V}, I_D = 7\text{ A}$ | Ch-1 | - | 0.01200 | 0.01440 | |
| | | $V_{GS} = 4.5\text{ V}, I_D = 15\text{ A}$ | Ch-2 | - | 0.00496 | 0.00620 | |
| Forward transconductance ^b | g_{fs} | $V_{GS} = 10\text{ V}, I_D = 10\text{ A}$ | Ch-1 | - | 57 | - | S |
| | | $V_{GS} = 10\text{ V}, I_D = 10\text{ A}$ | Ch-2 | - | 60 | - | |
| Dynamic ^a | | | | | | | |
| Input capacitance | C_{iss} | Channel-1 $V_{DS} = 15\text{ V}, V_{GS} = 10\text{ V}, f = 1\text{ MHz}$ Channel-2 $V_{DS} = 15\text{ V}, V_{GS} = 10\text{ V}, f = 1\text{ MHz}$ | Ch-1 | - | 580 | - | μF |
| | | | Ch-2 | - | 1290 | - | |
| Output capacitance | C_{oss} | | Ch-1 | - | 250 | - | |
| | | | Ch-2 | - | 660 | - | |
| Reverse transfer capacitance | C_{rss} | | Ch-1 | - | 30 | - | |
| | | | Ch-2 | - | 50 | - | |
| C_{rss}/C_{iss} ratio | | | Ch-1 | - | 0.052 | 0.103 | |
| | | | Ch-2 | - | 0.076 | 0.152 | |
| Total gate charge | Q_g | $V_{DS} = 15\text{ V}, V_{GS} = 10\text{ V}, I_D = 15\text{ A}$ | Ch-1 | - | 8.1 | 12.2 | nC |
| | | $V_{DS} = 15\text{ V}, V_{GS} = 10\text{ V}, I_D = 20\text{ A}$ | Ch-2 | - | 18.6 | 27.9 | |
| | | $V_{DS} = 15\text{ V}, V_{GS} = 4.5\text{ V}, I_D = 15\text{ A}$ | Ch-1 | - | 3.7 | 4.5 | |
| | | $V_{DS} = 15\text{ V}, V_{GS} = 4.5\text{ V}, I_D = 20\text{ A}$ | Ch-2 | - | 8.4 | 12.6 | |
| Gate-source charge | Q_{gs} | Channel-1 $V_{DS} = 15\text{ V}, V_{GS} = 4.5\text{ V}, I_D = 15\text{ A}$ | Ch-1 | - | 2.4 | - | |
| | | Ch-2 | - | 4.6 | - | | |
| Gate-drain charge | Q_{gd} | Channel-2 $V_{DS} = 15\text{ V}, V_{GS} = 4.5\text{ V}, I_D = 20\text{ A}$ | Ch-1 | - | 0.67 | - | |
| | | Ch-2 | - | 1.5 | - | | |
| Output charge | Q_{oss} | $V_{DS} = 15\text{ V}, V_{GS} = 0\text{ V}$ | Ch-1 | - | 6.5 | - | |
| | | | Ch-2 | - | 13.9 | - | |
| Gate resistance | R_g | $f = 1\text{ MHz}$ | Ch-1 | 0.24 | 1.2 | 2.4 | Ω |
| | | | Ch-2 | 0.2 | 1 | 2 | |



| SPECIFICATIONS ($T_J = 25\text{ }^\circ\text{C}$, unless otherwise noted) | | | | | | | | |
|--|--------------|--|------|------|------|------|----|----|
| PARAMETER | SYMBOL | TEST CONDITIONS | MIN. | TYP. | MAX. | UNIT | | |
| Dynamic ^a | | | | | | | | |
| Turn-on delay time | $t_{d(on)}$ | Channel-1 $V_{DD} = 15\text{ V}, R_L = 1.5\ \Omega$ $I_D \cong 10\text{ A}, V_{GEN} = 10\text{ V}, R_g = 1\ \Omega$ | Ch-1 | - | 8 | 20 | ns | |
| | | | Ch-2 | - | 12 | 24 | | |
| Rise time | t_r | | Ch-1 | - | 28 | 45 | | |
| | | | Ch-2 | - | 8 | 16 | | |
| Turn-off delay time | $t_{d(off)}$ | Channel-2 $V_{DD} = 15\text{ V}, R_L = 1.5\ \Omega$ $I_D \cong 10\text{ A}, V_{GEN} = 10\text{ V}, R_g = 1\ \Omega$ | Ch-1 | - | 15 | 25 | | |
| | | | Ch-2 | - | 22 | 33 | | |
| Fall time | t_f | | Ch-1 | - | 10 | 20 | | |
| | | | Ch-2 | - | 8 | 16 | | |
| Turn-on delay time | $t_{d(on)}$ | Channel-1 $V_{DD} = 15\text{ V}, R_L = 1.5\ \Omega$ $I_D \cong 10\text{ A}, V_{GEN} = 4.5\text{ V}, R_g = 1\ \Omega$ | Ch-1 | - | 15 | 25 | | |
| | | | Ch-2 | - | 22 | 35 | | |
| Rise time | t_r | | Ch-1 | - | 80 | 120 | | |
| | | | Ch-2 | - | 180 | 270 | | |
| Turn-off delay time | $t_{d(off)}$ | Channel-2 $V_{DD} = 15\text{ V}, R_L = 1.5\ \Omega$ $I_D \cong 10\text{ A}, V_{GEN} = 4.5\text{ V}, R_g = 1\ \Omega$ | Ch-1 | - | 10 | 20 | | |
| | | | Ch-2 | - | 26 | 39 | | |
| Fall time | t_f | | Ch-1 | - | 38 | 57 | | |
| | | | Ch-2 | - | 15 | 23 | | |
| Drain-Source Body Diode Characteristics | | | | | | | | |
| Continuous source-drain diode current | I_S | $T_C = 25\text{ }^\circ\text{C}$ | Ch-1 | - | - | 13.9 | A | |
| | | | Ch-2 | - | - | 25.8 | | |
| Pulse diode forward current ($t = 100\ \mu\text{s}$) | I_{SM} | | Ch-1 | - | - | 100 | | |
| | | | Ch-2 | - | - | 150 | | |
| Body diode voltage | V_{SD} | $I_S = 8\text{ A}, V_{GS} = 0\text{ V}$ $I_S = 10\text{ A}, V_{GS} = 0\text{ V}$ | Ch-1 | - | 0.83 | 1.2 | V | |
| | | | Ch-2 | - | 0.81 | 1.2 | | |
| Body diode reverse recovery time | t_{rr} | Channel-1 $I_F = 10\text{ A}, di/dt = 100\text{ A}/\mu\text{s}, T_J = 25\text{ }^\circ\text{C}$ Channel-2 $I_F = 10\text{ A}, di/dt = 100\text{ A}/\mu\text{s}, T_J = 25\text{ }^\circ\text{C}$ | Ch-1 | - | 26 | 52 | ns | |
| | | | Ch-2 | - | 17 | 68 | | |
| Body diode reverse recovery charge | Q_{rr} | | | Ch-1 | - | 26 | 52 | nC |
| | | | | Ch-2 | - | 5 | 10 | |
| Reverse recovery fall time | t_a | | Ch-1 | - | 14 | - | ns | |
| | | | Ch-2 | - | 6.5 | - | | |
| Reverse recovery rise time | t_b | | | Ch-1 | - | 12 | | - |
| | | | | Ch-2 | - | 10.5 | | - |

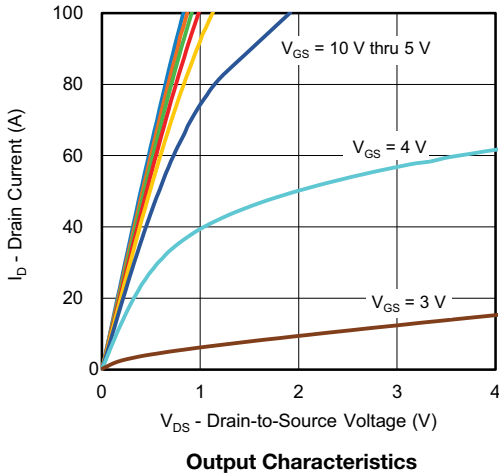
Notes

- a. Guaranteed by design, not subject to production testing
- b. Pulse test; pulse width $\leq 300\ \mu\text{s}$, duty cycle $\leq 2\%$

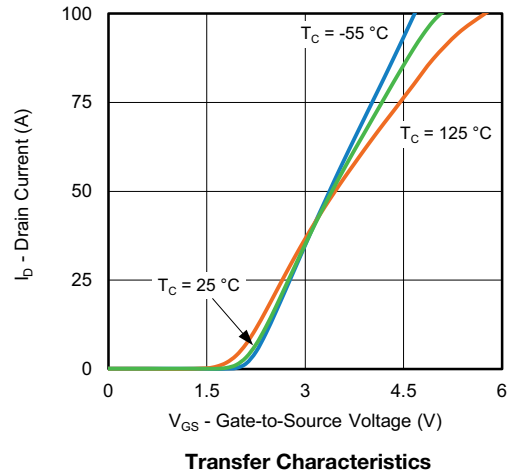
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



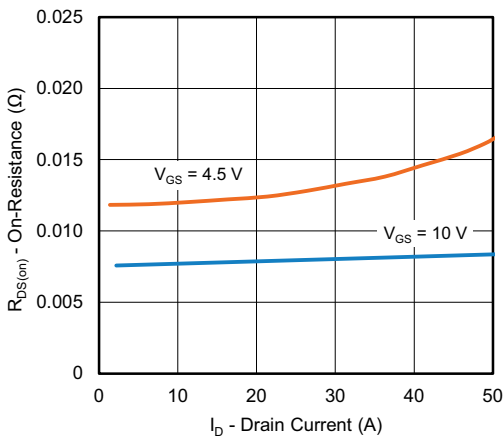
CHANNEL-1 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



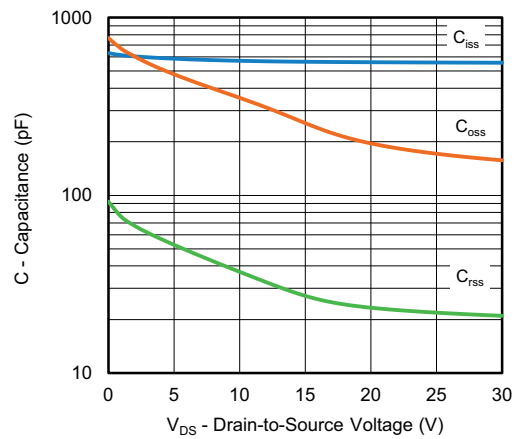
Output Characteristics



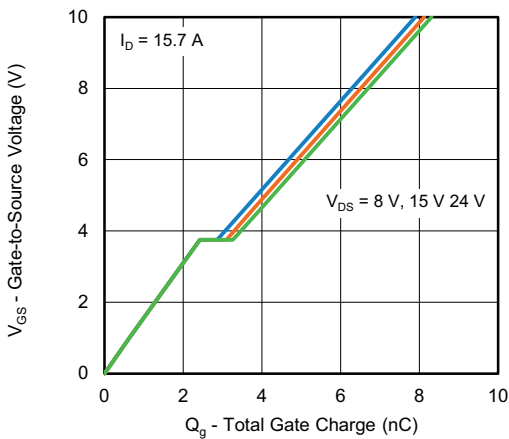
Transfer Characteristics



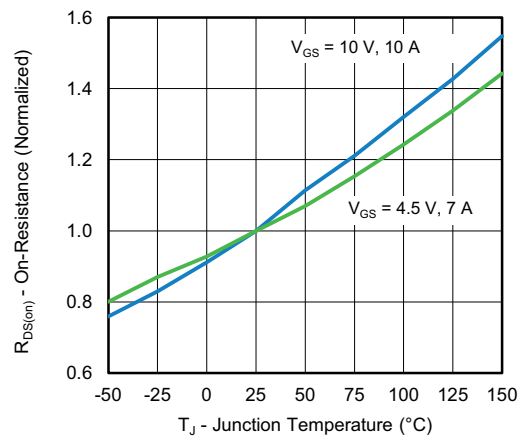
On-Resistance vs. Drain Current



Capacitance



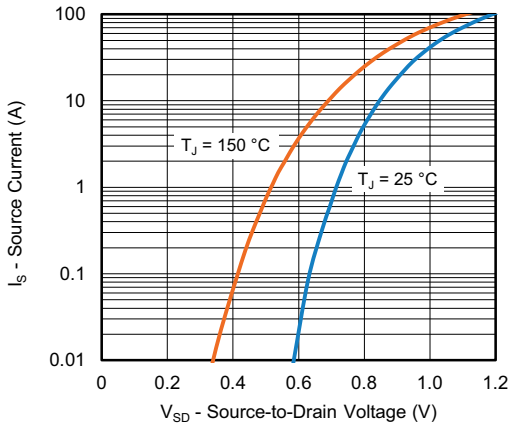
Gate Charge



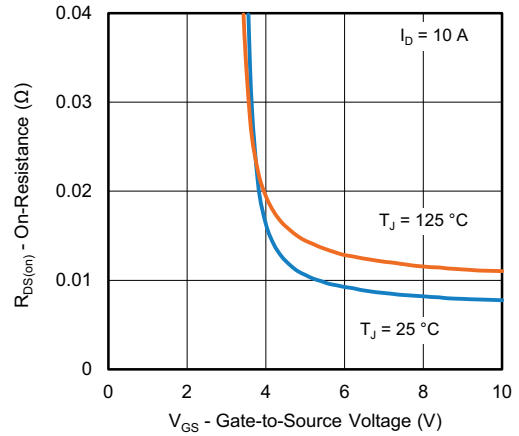
On-Resistance vs. Junction Temperature



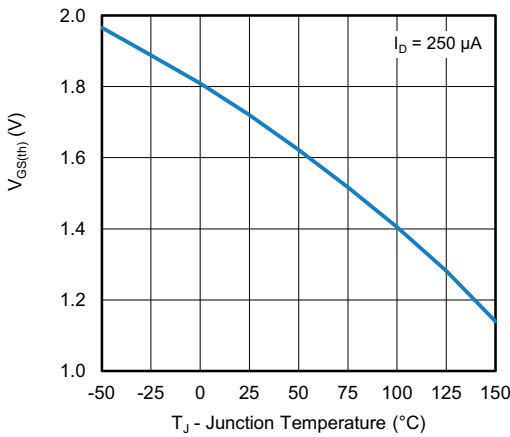
CHANNEL-1 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



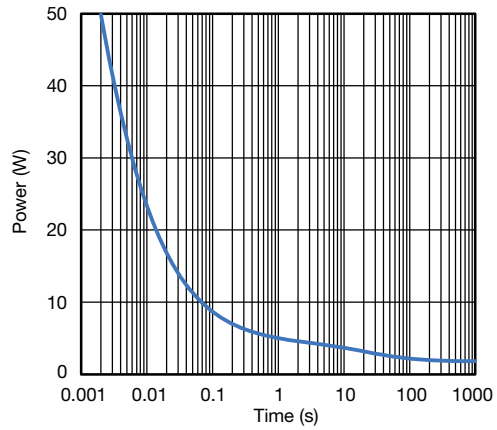
Source-Drain Diode Forward Voltage



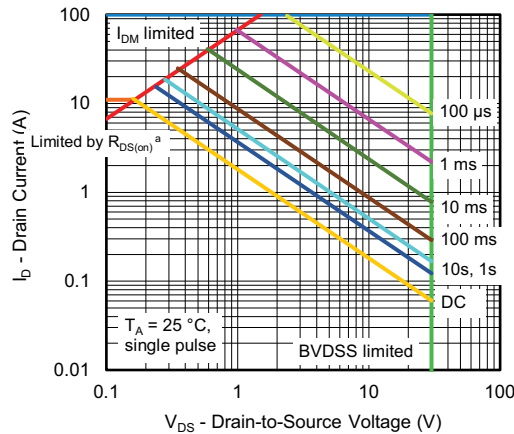
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



Single Pulse Power, Junction-to-Ambient



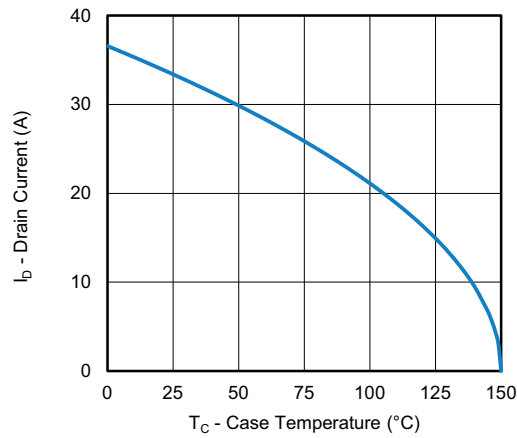
Safe Operating Area, Junction-to-Ambient

Note

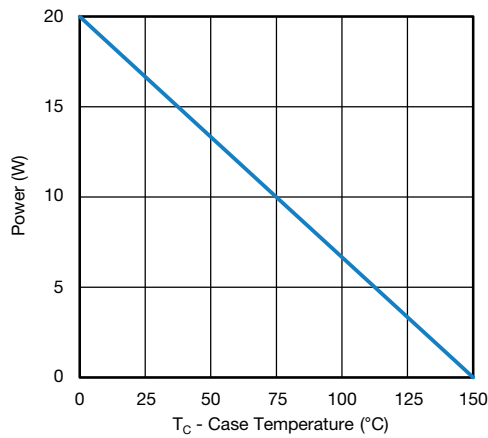
a. $V_{GS} >$ minimum V_{GS} at which $R_{DS(on)}$ is specified



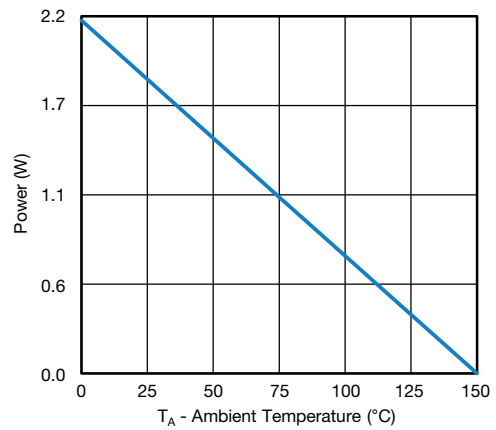
CHANNEL-1 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Current Derating ^a



Power, Junction-to-Case



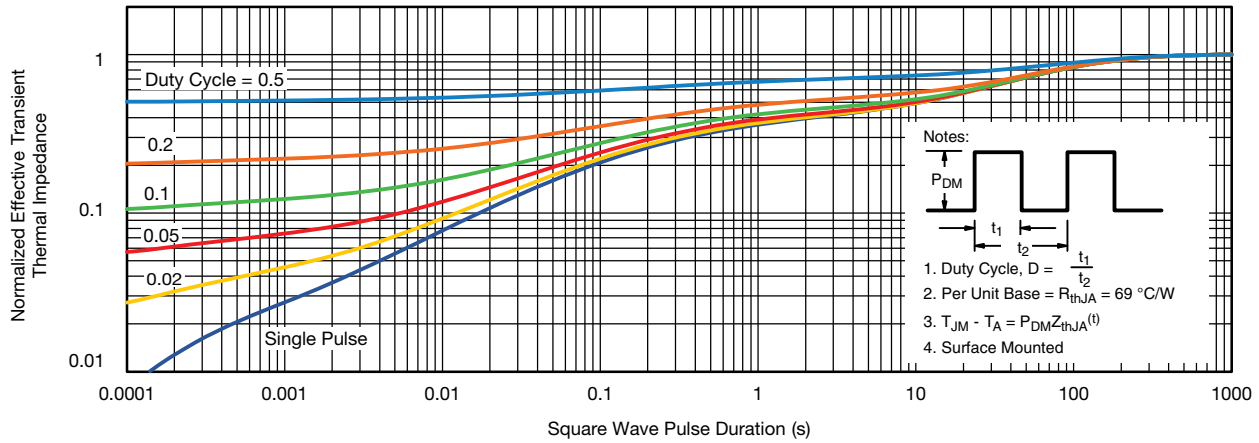
Power, Junction-to-Ambient

Note

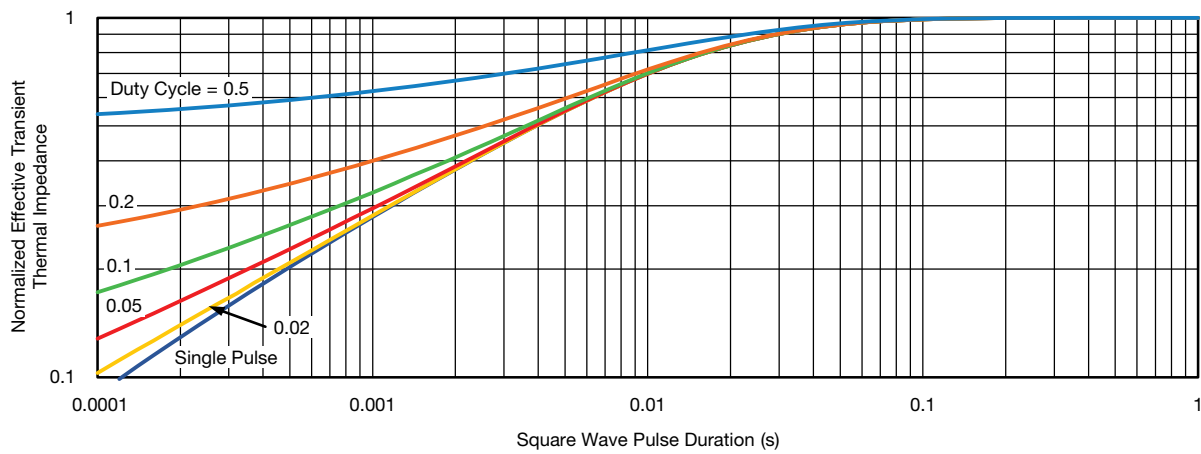
- a. The power dissipation P_D is based on T_J max. = 25 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit



CHANNEL-1 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



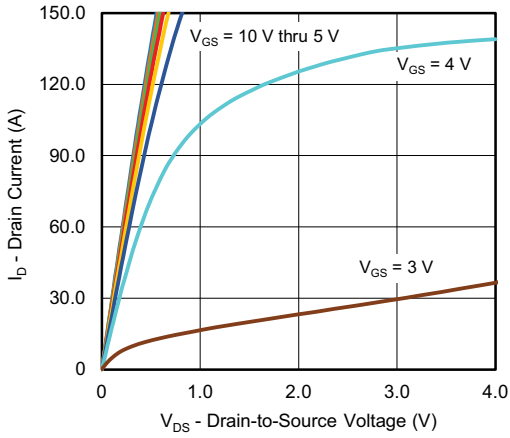
Normalized Thermal Transient Impedance, Junction-to-Ambient



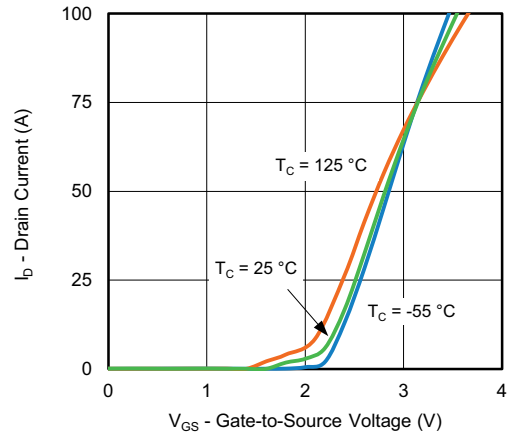
Normalized Thermal Transient Impedance, Junction-to-Case



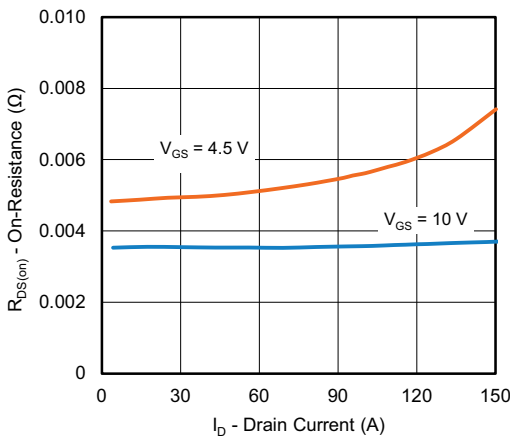
CHANNEL-2 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



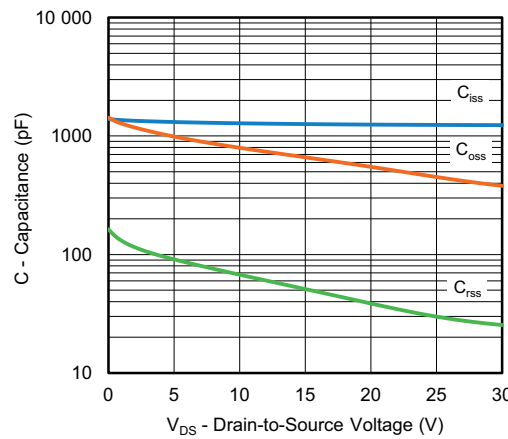
Output Characteristics



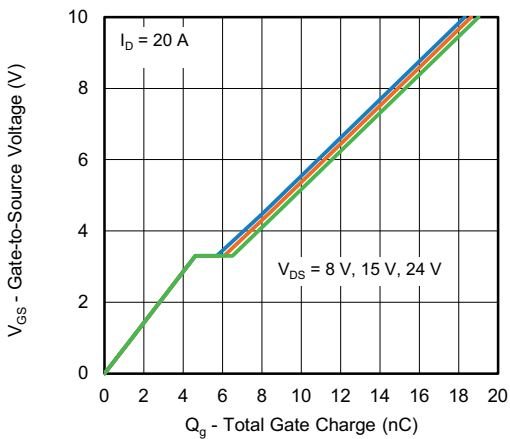
Transfer Characteristics



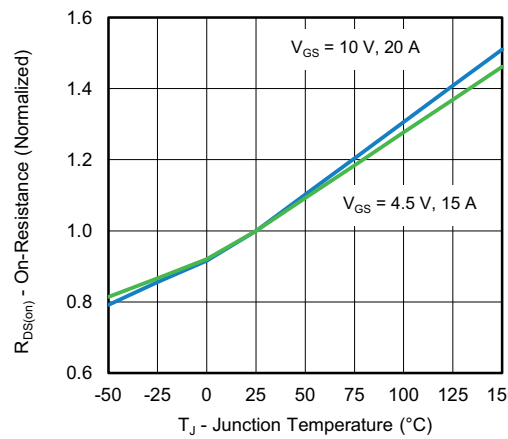
On-Resistance vs. Drain Current



Capacitance



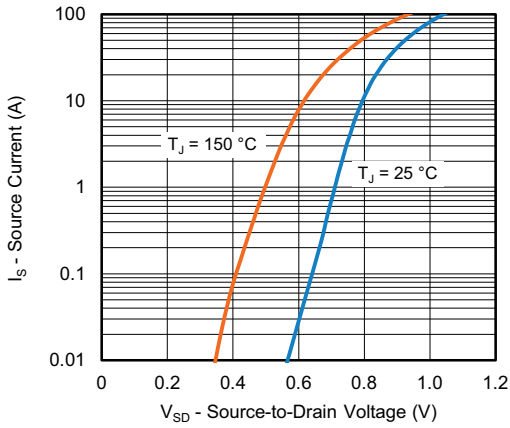
Gate Charge



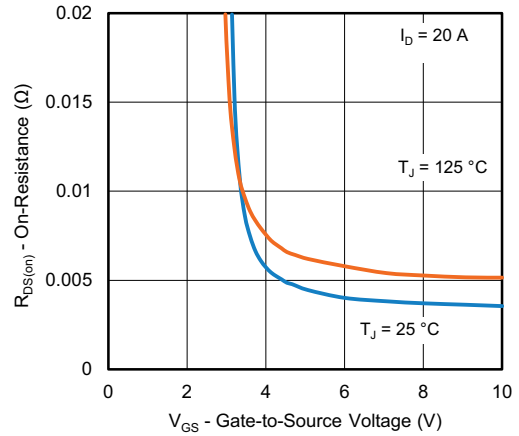
On-Resistance vs. Junction Temperature



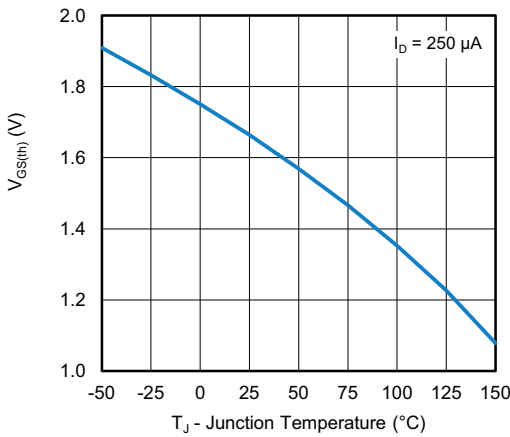
CHANNEL-2 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



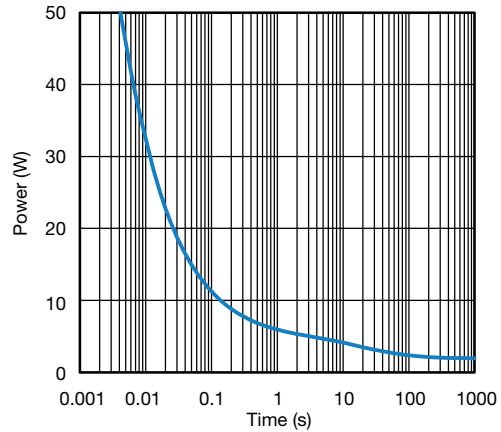
Source-Drain Diode Forward Voltage



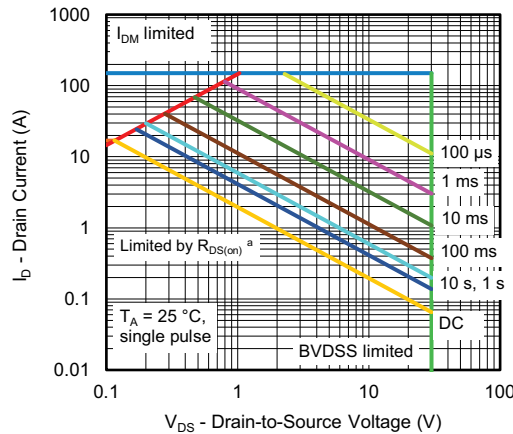
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



Single Pulse Power, Junction-to-Ambient



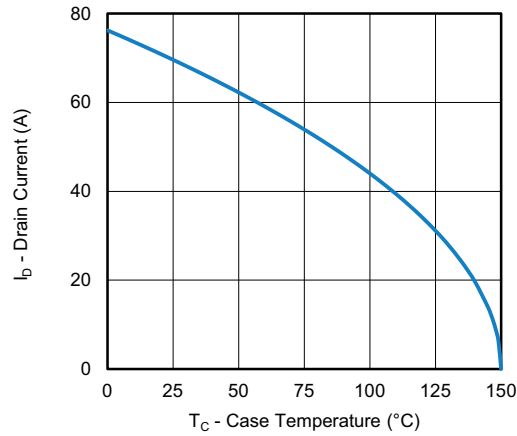
Safe Operating Area, Junction-to-Ambient

Note

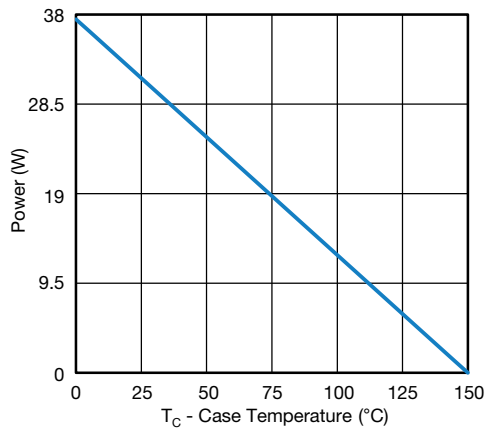
a. $V_{GS} >$ minimum V_{GS} at which $R_{DS(on)}$ is specified



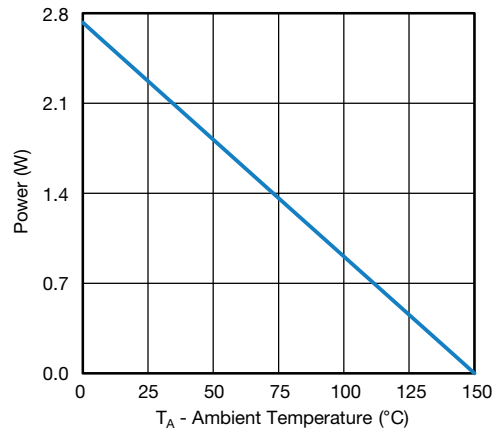
CHANNEL-2 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Current Derating ^a



Power, Junction-to-Case



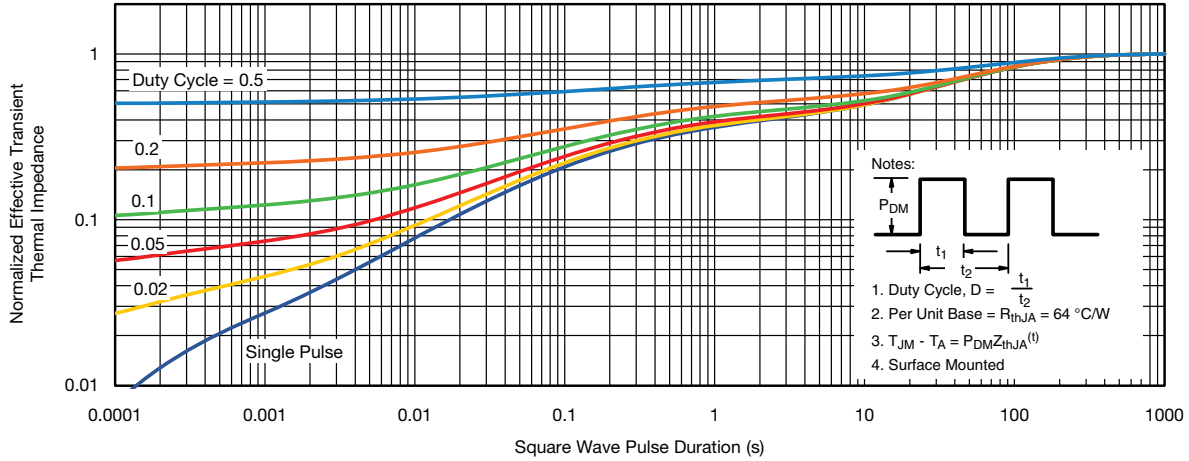
Power, Junction-to-Ambient

Note

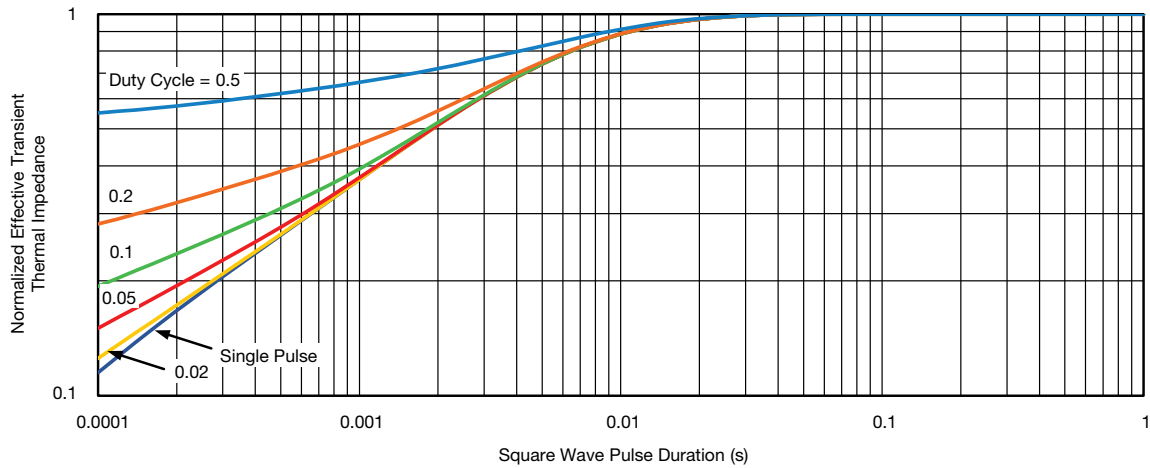
- a. The power dissipation P_D is based on T_J max. = 25 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit



CHANNEL-2 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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